





Test Report issued under the responsibility of:

TEST REPORT IEC/EN 60947-2

Low-voltage switchgear and controlgear - Part 2: Circuit-breakers

Report Reference No:	03601-A-14CB0043-S
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CB/CCA Testing Laboratory:	Suzhou Electrical Apparatus Science Research Institute Stock Co., Ltd.(EETI)
Address:	No.7 Yonghe Street, Binhe Road, New District, Suzhou, China
Applicant's name:	Zhejiang Tengen Electrics Co.,Ltd.
Address:	Tengen Industry Zone, Liushi, Yueqing, Zhejiang Province, P.R.China
Test specification:	
Standard:	 IEC 60947-2:2006 (4th Edition) and/or ■ EN 60947-2:2006 (4th Edition)
Test procedure:	CB/CCA
Non-standard test method	N/A
Test Report Form No:	IECEN60947_2B
Test Report Form(s) Originator:	KEMA
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Test item description:	Moulded Case Circuit-breaker
Trade Mark:	N/A
Manufacturer:	Zhejiang Tengen Electrics Co.,Ltd.
Model/Type reference:	DZ47MX-100C, DZ47MX-100D
Ratings	Ui: 500V; Ue:AC230V (1P+N) ,AC400V(3P+N); In:63A,80A,100A; Thermal magnetic over-current release; Utilization Category:A; Ics=Icu:6kA; 1P+N, 3P+N

Testing procedure and testing location:	2000年开发
CB/CCA Testing Laboratory:	Suzhou Electrical Apparatus Science Research Institute Stock Co., Ltd.(EETI)
Testing location/ address:	No.7 Yonghe Street, Binhe Road, New District, Suzhou, China
Associated CB Laboratory:	N/A 过验专用业
Testing location/ address:	N/A
Tested by (name + signature):	Chen Jiwen
Approved by (+ signature):	Hu Delin
Testing procedure: TMP	N/A
Tested by (name + signature):	N/A
Approved by (+ signature):	N/A
Testing location/ address:	N/A
Testing procedure: WMT	N/A
Tested by (name + signature):	N/A
Witnessed by (+ signature):	N/A
Approved by (+ signature):	N/A
Testing location/ address:	N/A
Testing procedure: SMT	N/A
Tested by (name + signature):	N/A
Approved by (+ signature):	N/A
Supervised by (+ signature):	N/A
Testing location/ address:	N/A
Testing procedure: RMT	N/A
Tested by (name + signature):	N/A
Approved by (+ signature)	N/A
Supervised by (+ signature):	N/A
Testing location/ address:	N/A